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FCP16N60 / FCPF16N60 N-Channel SuperFET[®] MOSFET 600 V, 16 A, 260 mΩ

Features

- 650V @ T_{.I} = 150°C
- Typ. R_{DS(on)} = 220 mΩ
- Ultra Low Gate Charge (Typ. Q_g = 55 nC)
- Low Effective Output Capacitance (Typ. C_{oss(eff.)} = 110 pF)
- 100% Avalanche Tested

Applications

- Solar Inverter
- AC-DC Power Supply

August 2014

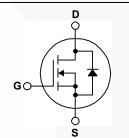
FCP16N60 / FCPF16N60 — N-Channel SuperFET[®] MOSFET

Description

SuperFET[®] MOSFET is Fairchild Semiconductor's first generation of high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low onresistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications.







Absolute Maximum Ratings

Symbol		Parameter		FCP16N60	FCPF16N60	Unit	
V _{DSS}	Drain-Source Voltage			6	V		
ID	Drain Current	- Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		16 10.1	16* 10.1*	A A	
I _{DM}	Drain Current	- Pulsed	(Note 1)	48	48*	А	
V _{GSS}	Gate-Source Voltage			±	V		
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	450		mJ	
I _{AR}	Avalanche Current		(Note 1)	16		А	
E _{AR}	Repetitive Avalanche Energy		(Note 1)	20.8		mJ	
dv/dt	Peak Diode Recov	/ery dv/dt	(Note 3)	4.5		V/ns	
P _D	Power Dissipation	(T _C = 25°C) - Derate Above 25°C		167 1.33	37.9 0.3	W W/°C	
T _{J,} T _{STG}	Operating and Storage Temperature Range		-55 to +150		°C		
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			3	°C		

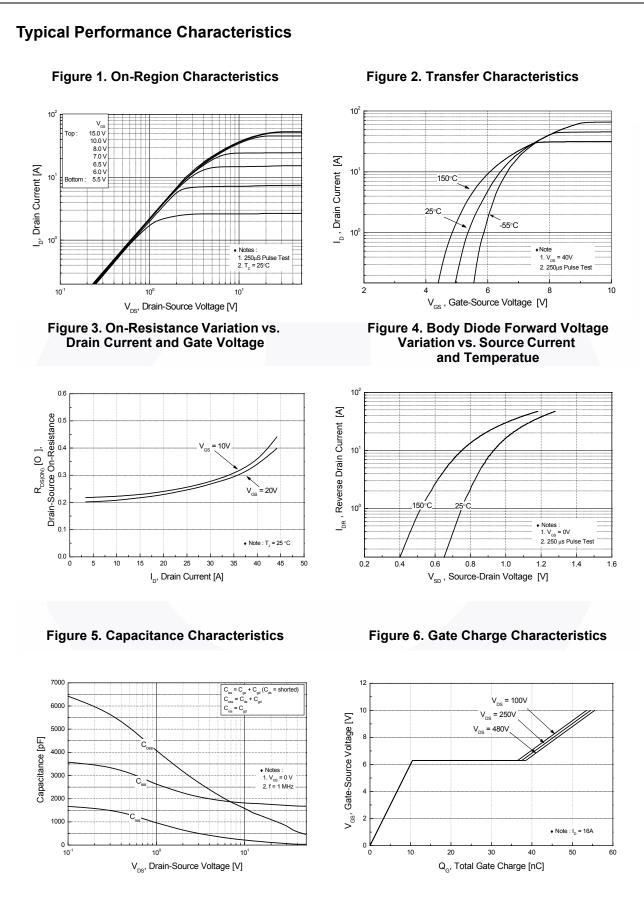
*Drain current limited by maximum junction temperature.

Thermal Characteristics

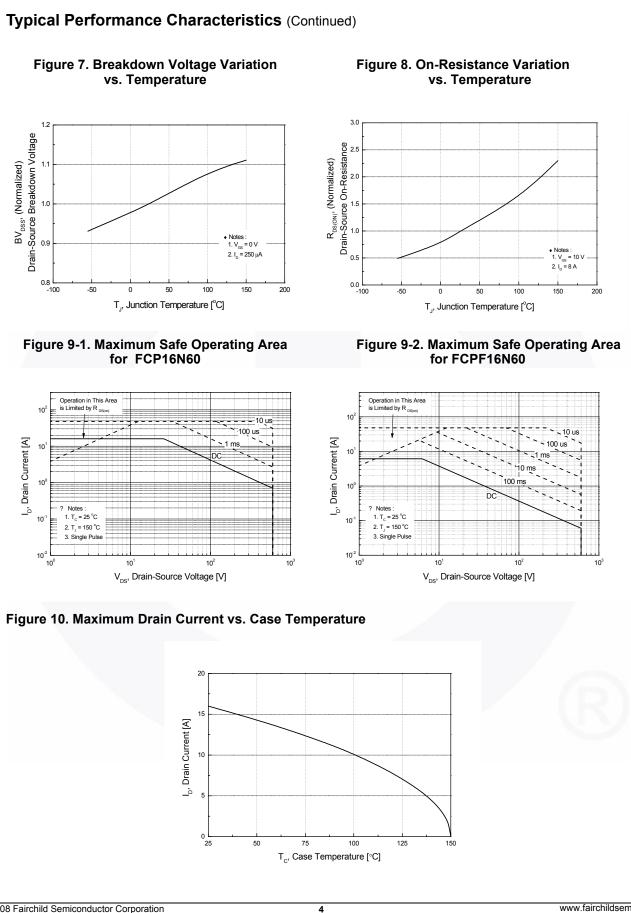
Symbol	Parameter	FCP16N60	FCPF16N60	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.75	3.3	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	°C/W

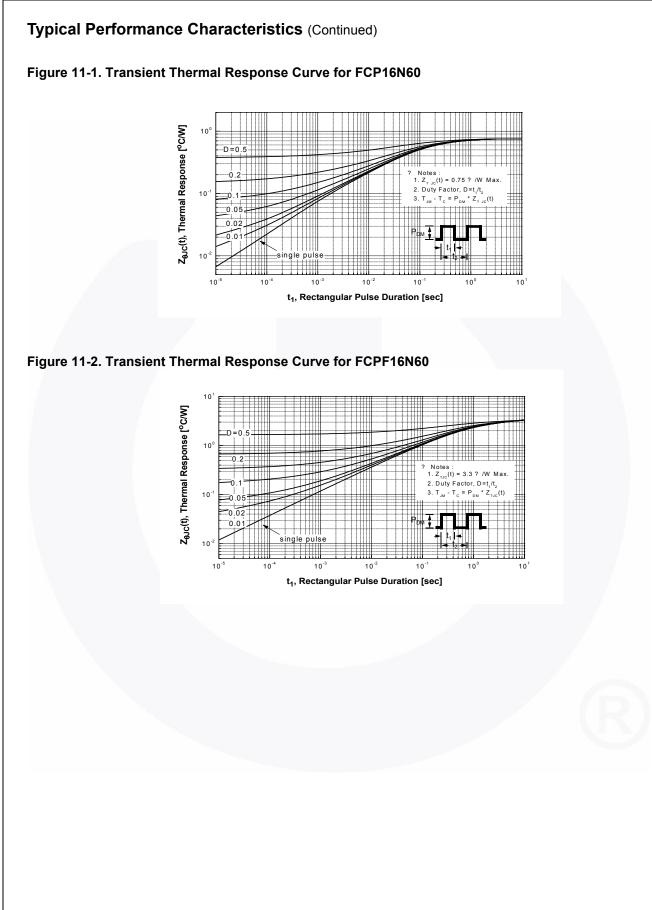
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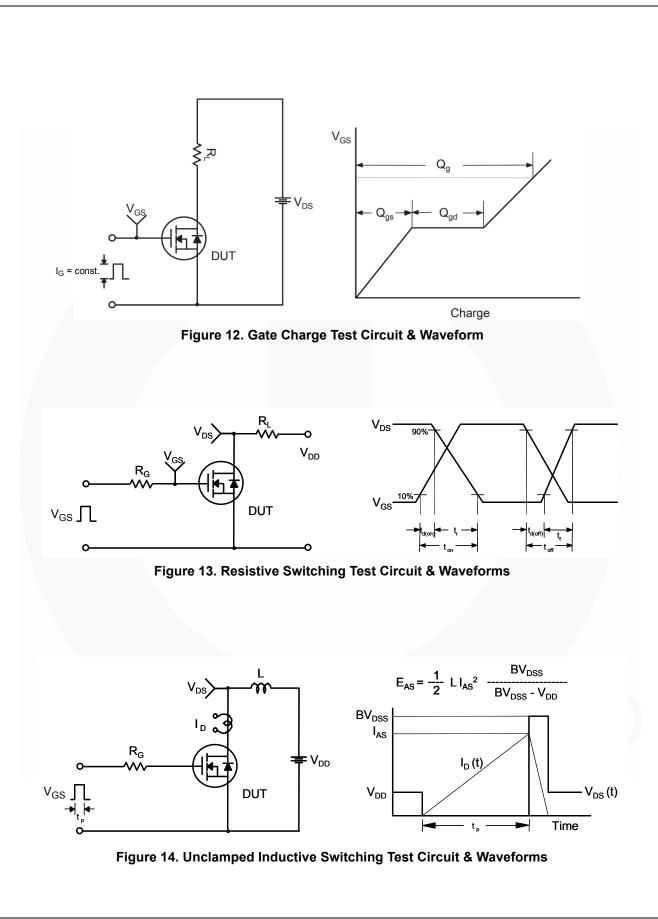
60		Package	Packing Method	Reel Size	Тар	e Width	Qua	ntity
	FCP16N60	TO-220	Tube	N/A		N/A	50 units	
FCPF16N60 FCPF16N60 TO			Tube	N/A		N/A	50 units	
Charac	cteristics T _C = 25	^o C unless	otherwise noted.					
	Parameter					Тур.	Max.	Unit
teristics							I	
			I _D = 250 μA. V _{CS} = 0 V.	T ₁ = 25 ^o C	600	-	_	V
Drain to Source Breakdown Voltage		10 An	$I_D = 250 \ \mu\text{A}, \ V_{GS} = 0 \ V, \ T_J = 150^{\circ}\text{C}$			650	-	V
Breakdown Voltage Temperature Coefficient			$I_D = 250 \ \mu$ A, Referenced to 25° C			0.6	-	V/ºC
Drain-Source Avalanche Breakdown Voltage			V _{GS} = 0 V, I _D = 16 A			700	-	v
S Zero Gate Voltage Drain Cur		V _{DS} = 600 V, V _{GS} = 0 V		-	-	1		
			V _{DS} = 480 V, T _C = 125 ^o C		-	-	10	μA
Gate to Body Leakage Current			V_{GS} = ±30 V, V_{DS} = 0 V	,	-	-	±100	nA
teristics								
Gate Threshold Voltage			$V_{CS} = V_{DS}$. $I_{D} = 250 \mu A$			-	5.0	V
Static Drain to Source On Resistance						0.55	0.26	Ω
Forward Transconductance						11.5	-	S
haracteri	stics			I. I.		1	1	
1					-	1730	2250	pF
Output Ca	pacitance				-	960	1150	pF
	•		t = 1 MHz	= 1 MHZ		85	-	pF
Output Capacitance			V _{DS} = 480 V, V _{GS} = 0 V, f = 1 MHz		-	45	60	pF
					-	110	-	pF
					-	55	70	nC
Gate to Source Gate Charge			$V_{GS} = 10 V$ (Note 4)		-	10.5	13	nC
						28	-	nC
Equivalent	ů		f = 1 MHz			1.7	-	Ω
Characte	ristics		1					1
1					-	42	85	ns
Turn-On Rise Time			$V_{DD} = 300 \text{ V}, \text{ I}_{D} = 16 \text{ A},$ $V_{CS} = 10 \text{ V}, \text{ R}_{C} = 25 \Omega$		-			ns
					-			ns
			(Note 4)		-			ns
					-		16	А
			-	-	48	Α		
					-	-	1.4	V
			$V_{GS} = 0 V, I_{SD} = 16 A,$ $dI_F/dt = 100 A/\mu s$		-	435	-	ns
	ecovery Charge				-	7.0	-	μC
	teristics Drain to Si Breakdown Coefficient Drain-Sou Voltage Zero Gate Gate to Bo teristics Gate Thre Static Drai Forward T haracteri Input Capa Output Ca Reverse T Output Ca Effective O Total Gate Gate to Sc Gate to Dr Equivalent Character Turn-On D Turn-On R Turn-Off D Turn-Off Fa Ce Diode Maximum I Drain to Sc	Parameter teristics Drain to Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Drain-Source Avalanche Breakdow Voltage Zero Gate Voltage Drain Current Gate to Body Leakage Current teristics Gate Threshold Voltage Static Drain to Source On Resista Forward Transconductance haracteristics Input Capacitance Output Capacitance Output Capacitance Output Capacitance Output Capacitance Total Gate Charge at 10V Gate to Drain "Miller" Charge Equivalent Series Resistance Characteristics Turn-On Delay Time Turn-Off Delay Time Turn-Off Fall Time Ce Diode Characteristics Maximum Continuous Drain to Source	Parameter teristics Drain to Source Breakdown Voltage Breakdown 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V$, $V_{DS} = 480 \ V$, $T_C = 1250$ (Gate to Body Leakage CurrentGate Threshold Voltage $V_{GS} = \pm 30 \ V$, $V_{DS} = 0 \ V$ Static Drain to Source On Resistance $V_{GS} = 10 \ V$, $I_D = 8 \ A$ Forward Transconductance $V_{DS} = 40 \ V$, $I_D = 8 \ A$ haracteristicsInput CapacitanceOutput Capacitance $V_{DS} = 480 \ V$, $V_{GS} = 0 \ V$, f = 1 MHzOutput Capacitance $V_{DS} = 480 \ V$, $V_{GS} = 0 \ V$, f Gate to Source Gate ChargeVoltage to Drain "Miller" ChargeF = 1 \ MHzEquivalent Series Resistancef = 1 \ MHzCharacteristicsTurn-On Delay Time Turn-Off Delay TimeTurn-Off Delay Time $V_{DD} = 300 \ V$, $I_D = 16 \ A$, $V_{GS} = 10 \ V$, $G_S = 25 \ \Omega$ Maximum Continuous Drain to Source Diode Forward Current Maximum Pulsed Drain to Source Diode Forward Current Drain to Source Diode Forward Current Drain to Source Diode Forward Current Drain to Source Diode Forward Current	ParameterTest ConditionsteristicsIn the Source Breakdown VoltageDrain to Source Breakdown Voltage 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-Output Capacitance Output Capacitance $V_{DS} = 0 \ V, 0_{GS} = 0 \ V, I = 1 \ MHz$ -Effective Output Capacitance Gate to Drain "Miller" Charge $V_{DS} = 10 \ V, 0_{SS} = 0 \ V, I = 1 \ MHz$ -CharacteristicsTurn-On Delay Time Turn-On Bleay TimeV_{DD} = 300 \ V, I_D = 16 \ A, 0 \ V_{GS} = 10 \ V, 0_{GS} = 10 \	$\begin{tabular}{ c c c c c } \hline Parameter Test Conditions Min. 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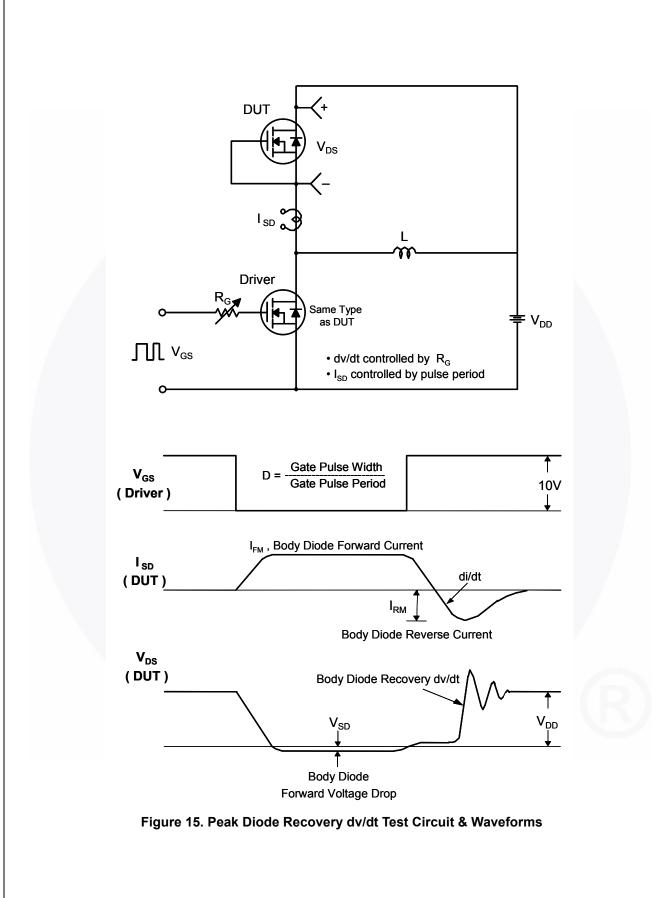




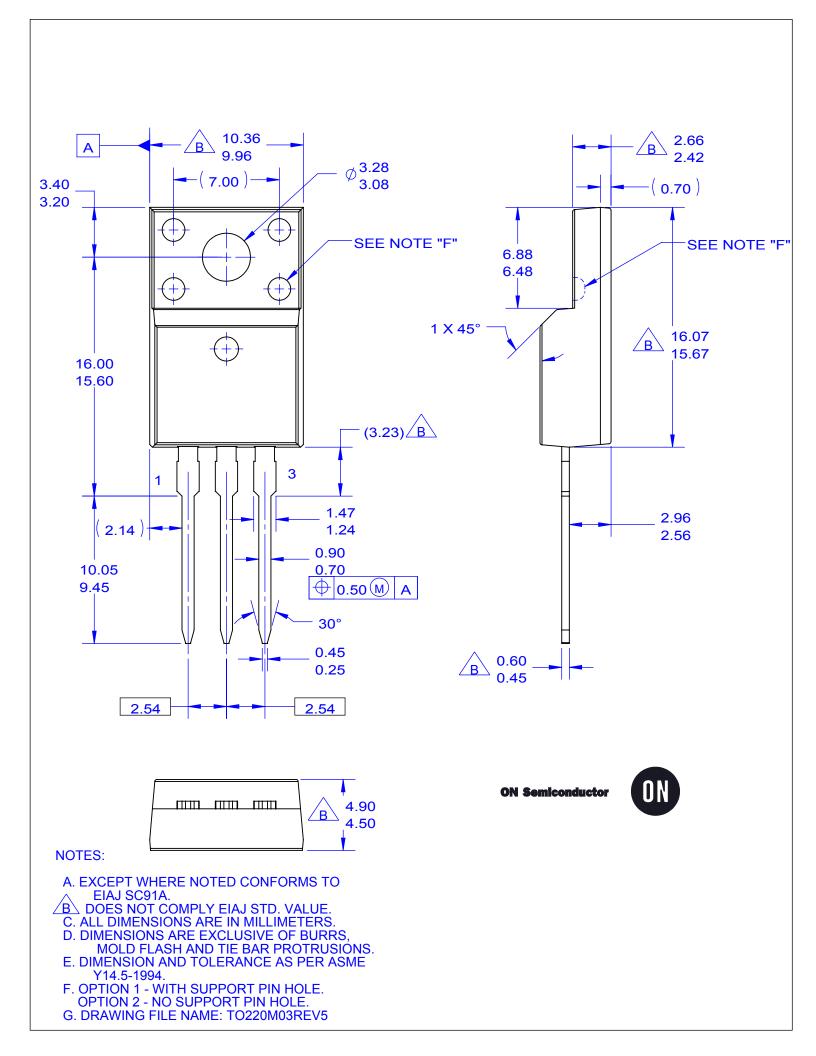


FCP16N60 / FCPF16N60 — N-Channel SuperFET[®] MOSFET

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